Sea	I-	AI_	4
N 02	rcn	NO	700
JEO		1 T L	



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/623,075	BANERJEE ET AL.	
Examiner	Art Unit	
David J. Blanchard	1643	

SEARCHED			
Class	Subclass	Date	Examiner
		,	
			
	•		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
SEQ ID	Nos:1-4	5/2/2007	DB	

)_
DATE	EXMR
5/2/2007	DB
5/7/2007	DB
5/7/2007	DB
:	
	5/2/2007